

<b>Notice of References Cited</b>	Application/Control No. 10/633,083		Applicant(s)/Patent Under Reexamination CHO ET AL.	
	Examiner EBENEZER SACKKEY		Art Unit 1626	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,849,652	02-2005	Cho et al.	514/383
	B	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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